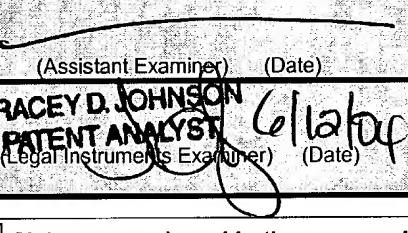
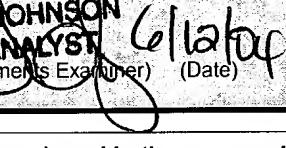


Issue Classification 	Application No.		Applicant(s)	
	09/846,430		LAI ET AL.	
	Examiner		Art Unit	
	Jeffrey Siew		1637	

ISSUE CLASSIFICATION

ORIGINAL		CROSS REFERENCE(S)						
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
435	6	435	7.1	91.1	91.2	287.2		
INTERNATIONAL CLASSIFICATION		536	22.1	23.1	24.3	24.31	24.32	24.33
C 12 Q	1168							
C 12 P	19139							
C 12 M	1134							
C 07 H	21102							
C 07 H	21104							
 (Assistant Examiner) (Date)		JEFFREY SIEW PRIMARY EXAMINER  (Primary Examiner)		6/11/04 (Date)		Total Claims Allowed: 24		
TRACEY D. JOHNSON PATENT ANALYST Legal Instruments Examiner  (Date)		O.G. Print Claim(s)		O.G. Print Fig				

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1	16	31	61	91	121	151
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2	3	20	33	63	93	123	153
3	4	21	34	64	94	124	154
4	5	22	35	65	95	125	155
5	6	23	36	66	96	126	156
6	7	24	37	67	97	127	157
7	8	25	38	68	98	128	158
8	9	26	39	69	99	129	159
9	10	27	40	70	100	130	160
10	11	28	41	71	101	131	161
11	12	29	42	72	102	132	162
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13	14		44	74	104	134	164
14	15		45	75	105	135	165
15	16		46	76	106	136	166
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17	18		48	78	108	138	168
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20	21		51	81	111	141	171
21	22		52	82	112	142	172
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23	24		54	84	114	144	174
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26	27		57	87	117	147	177
27	28		58	88	118	148	178
28	29		59	89	119	149	179
29	30		60	90	120	150	180